

## **Search Notes**



**Application/Control No.**

10/707,045

**Examiner**

John F. Ramirez

**Applicant(s)/Patent under  
Reexamination**

WEYERS ET AL.

## **Art Unit**

3737

**SEARCHED**

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner